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| Notice of References Cited | | Application/Control No. 10/767,480 | Applicant(s)/Patent Under Reexamination RUBIN ET AL. | |
| | | Examiner BEN C. WANG | Art Unit 2192 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------------|----------------|
| * | A | US-7,353,503 B2 | 04-2008 | Nair et al. | 717/151 |
| * | B | US-2004/0128660 A1 | 07-2004 | Nair et al. | 717/156 |
| * | C | US-6,751,792 | 06-2004 | Nair, Sreekumar Ramakrishnan | 717/161 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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